

< HVMOSFET MODULE >

FMF200DC-66BE

 HIGH POWER SWITCHING USE

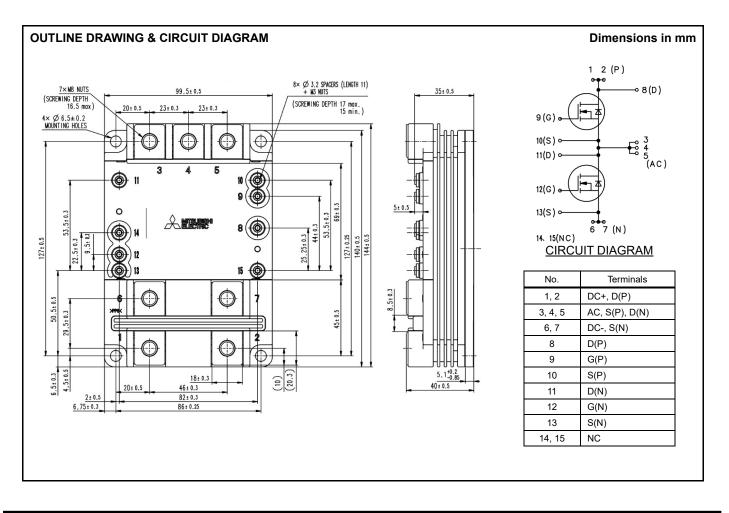
 INSULATED TYPE
 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

FMF200DC-66BE



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



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MAXIMUM RATINGS

Item	Symbol	Condition			Unit
Drain-Source voltage, specified gate-source voltage	V _{DSX}	V _{GS} = -7 V	3300	V	
Gate-Source voltage	V _{GSS}	V _{DS} = 0 V	$V_{DS} = 0 V$ $T_j = -40 \sim 175 °C$		
Drain current	I _D	V_{GS} = 17 V , T _c = 105 °C , AC terminal output current (Note 1)		200	А
Drain current	I _{DP}	Non repetitive pulse	$T_j = T_{op}$	400	А
Reverse drain current (FWD forward current)	Is	V_{GS} = -7 V , T _c = 103 °C , AC terminal output current(Note 1)(No	ote 2)	200	А
Reverse drain current (FWD forward current)	I _{SP}	Non repetitive pulse(Note 2)	$T_j = T_{op}$	400	А
Total power dissipation	P _{tot}	T _c = 25 °C , MOSFET part(Note 3)	2080	W	
Isolation voltage	V _{isol}	Charge part to the baseplate RMS sinusoidal. 60Hz 1min	6000	Vrms	
Partial discharge charge	Q _{pd}	Charged part to the baseplate RMS sinusoidal, 60 Hz 1min V1 = 3500 V, V2 = 2600 V(acc. to IEC 61287-1)	10	pC	
Junction temperature	Tj	Maximum temperature range in off-state or on-state(non-switching	-40~175	°C	
Case temperature	T _c	Maximum case temperature range in on-state		-40~150	°C
Storage temperature	T _{stg}	Maximum case temperature range in off-state	-50~175	°C	
Operating junction temperature	T _{jop}	Maximum junction temperature range for switching operation			°C
Short-circuit withstand pulse duration	t _{pSC}	V_{DD} = 2500 V , V_{GS} = +17 / -7 V , L_s = 40 nH , V_{GS} 50%- V_{GS} 50% T_j = T_{op}		1.7	μs
Short circuit energy	E _{sc}	$V_{DD} = 2500 \text{ V}$, F(t)weibull=1% $T_j = T_{op}$		8.7	J
Non-repetitive surge forward current	I _{FSM}	$t_{\rm b}$ = 10ms, F(t)weibull=1%, Half sinewave T _i = 175 °C		1.4	kA
I2t value	l ² t	$t_p = 10$ ms, F(t)weibull=1%, Half sinewave			kA ² s

ELECTRICAL CHARACTERISTICS

ltem	Symbol	Conditions		Limits			Unit
nem	Symbol	Conditions		Min.	Тур.	Max.	Onit
Gate-source leakage current	I _{GSS}	$V_{DS} = 0 V$, $V_{GS} = V_{GSS}$	T _i = 25 °C	-0.5	-	0.5	μA
			T _j = 25 °C	-	0.8	-	μA
Drain-source cut-off current	I _{DSX}	$V_{DS} = V_{DSX}$, $V_{GS} = -7$ V	T _j = 150 °C	-	12.5	-	μA
			T _j = 175 °C	-	20.0	750	μA
			T _j = 25 °C	1.60	2.10	2.60	V
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = 10 \text{ V}$, $I_D = 20 \text{mA}$	T _j = 150 °C	-	1.50	-	V
			T _i = 175 °C	0.90	1.45	1.90	V
		$V_{DS} = V_{DS(on)}$, $V_{GS} = 17 V$	T _j = 25 °C	-	8.00	-	mΩ
Drain-source on resistance	r _{DS(on)}		T _j = 150 °C	-	17.25	-	mΩ
			T _i = 175 °C	-	20.00	24.25	mΩ
Drain-source on-state voltage		I _D = 200 A , V _{GS} = 17 V (Note 4)	T _j = 25 °C	-	1.60	-	V
	V _{DS(on)}		T _j = 150 °C	-	3.45	-	V
			T _i = 175 °C	-	4.00	4.85	V
Source-drain voltage		I _S = 200 A , V _{GS} = 17 V (Note 4)	T _j = 25 °C	-	1.45	-	V
	V _{SD(on)}		T _j = 150 °C	-	3.25	-	V
			T _j = 175 °C	-	3.80	4.40	V
		I _S = 200 A , V _{GS} = 0 V (Note 4)	T _j = 25 °C	-	2.00	-	V
Source-drain voltage	V _{SD}		T _j = 150 °C	-	3.85	-	V
			T _i = 175 °C	-	4.35	5.00	V
		I _S = 200 A , V _{GS} = -7 V (Note 4)	T _j = 25 °C	-	2.00	-	V
Source-drain voltage	V _{SD(off)}		T _i = 150 °C	-	3.85	-	V
			T _i = 175 °C	-	4.35	5.00	V
Input capacitance	C _{iss}	V _{DS} = 10 V , V _{GS} = 0 V , f = 100kHz , 1/2 module	T _i = 25 °C	-	27.6	-	nF
Output capacitance	C _{oss}	V _{DS} = 10 V , V _{GS} = 0 V , f = 100kHz , 1/2 module	T _i = 25 °C	-	17.6	-	nF
Reverse transfer capacitance	C _{rss}	V _{DS} = 10 V , V _{GS} = 0 V , f = 100kHz , 1/2 module	T _i = 25 °C	-	0.7	-	nF
Gate charge	Q _G	V _{DD} = 1800 V , I _D = 200 A , V _{GS} = +17 / -7 V , 1/2 module	T _i = 25 °C	-	0.8	-	μC

< HVMOSFET MODULE > FMF200DC-66BE HIGH POWER SWITCHING USE INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

ELECTRICAL CHARACTERISTICS

Item	Symbol	Conditions			Limits		Unit
nem	Symbol	Conditions		Min.	Тур.	Max.	Onit
Turn-on delay time	t _{d(on)}	V_{DD} = 1800 V , I_D = 200 A , V_{GS} = +17 / -7 V , L_s = 40 nH	: +17 / -7 ∨ , L _s = 40 nH		-	0.37	μs
Rise time	t _r	V_{DD} = 1800 V , I_{D} = 200 A , V_{GS} = +17 / -7 V , L_{s} = 40 nH	T _i = 175 °C	-	-	0.23	μs
Turn on (nuitabing) on any		V _{DD} = 1800 V , I _D = 200 A , V _{GS} = +17 / -7 V , L _s = 40 nH	T _i = 25 °C	-	0.07	-	J
Turn-on (switching) energy per pulse 10% integral	E _{on(10%)}		T _j = 150 °C	-	0.06	-	J
		$R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 6.0 $\Omega,$ Inductive load	T _j = 175 °C	-	0.06	-	J
		(-1000)(-1-200)(-1)(-100)	T _i = 25 °C	-	0.07	-	J
Turn-on (switching) energy per pulse	Eon	$V_{DD} = 1800 \text{ V}$, $I_D = 200 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _i = 150 °C	-	0.06	-	J
		$R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 6.0 $\Omega,$ Inductive load	T _i = 175 °C	-	0.06	-	J
		V _{DD} = 1800 V , I _D = 200 A , V _{GS} = +17 / -7 V , L _s = 40 nH R ₂₍₋₁₎ = 1.5 Q R ₂₍₋₁₀₎ = 6.0 Q Inductive load	T _i = 25 °C	-	2.7	-	μC
Total capacitive charge	Q _c		T _i = 150 °C	-	3.1	-	μC
	-		T _i = 175 °C	-	3.1	-	μC
Diode turn-off energy (per pulse)	E _{off_Diode(10%)}	V_{DD} = 1800 V , I_D = 200 A , V_{GS} = +17 / -7 V , L_s = 40 nH $R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 6.0 Ω , Inductive load	T _i = 25 °C	-	0.24	-	mJ
			T _i = 150 °C	-	-	-	mJ
			T _i = 175 °C	-	0.54	-	mJ
	E _{off_Diode}		T _i = 25 °C	-	0.34	-	mJ
Diode switching off energy of diode		$V_{DD} = 1800 \text{ V}$, $I_D = 200 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _i = 150 °C	-	-	-	mJ
		$R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 6.0 Ω , Inductive load	T _i = 175 °C	-	0.65	-	mJ
Turn-off delay time	t _{d(off)}	V _{DD} = 1800 V , I _D = 200 A , V _{GS} = +17 / -7 V , L _s = 40 nH	T _i = 175 °C	-	-	0.94	μs
Fall time	t _f	$V_{DD} = 1800 \text{ V}$, $I_D = 200 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _i = 175 °C	-	-	0.40	μs
	E-#(40%)	V _{DD} = 1800 V , I _D = 200 A , V _{GS} = +17 / -7 V , L _s = 40 nH	T _i = 25 °C	-	0.03	-	J
Turn-off (switching) energy per pulse 10% integral			T _i = 150 °C	-	0.03	-	J
		$R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 6.0 $\Omega,$ Inductive load	T _i = 175 °C	-	0.03	-	J
			T _i = 25 °C	-	0.03	-	J
Turn-off (switching) energy per pulse	E _{off}	V_{DD} = 1800 V , I_{D} = 200 A , V_{GS} = +17 / -7 V , L_{s} = 40 nH	T _i = 150 °C	-	0.03	-	J
	511	$R_{G(on)} = 1.5 \Omega$, $R_{G(off)} = 6.0 \Omega$, Inductive load	T _i = 175 °C	-	0.03	-	J

THERMAL CHARACTERISTICS

Item	Symbol	Conditions		Limits		
	Symbol			Тур.	Max.	Unit
Thermal resistance junction to case	R _{th(j-c)}	Junction to Case, MOSFET + embeded SBD part, 1/2 module	-	-	72.0	K/kW
Contact thermal resistance case to heatsink	R _{th(c-s)}	Case to heat sink, λ_{grease} = 1W/m·K, $D_{(c-s)}$ = 70µm, 1/2 module	-	57.0	-	K/kW

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MECHANICAL CHARACTERISTICS

Item Svr	Symbol	ol Conditions		Limits			
Symbol		Conditions		Тур.	Max.	Unit	
Mounting torque	Mt	Main terminal screw M8 This is the case when installing the product on the bus bar		-	22.0	N∙m	
Mounting torque	Mt	Mounting screw M6	3.0	-	6.0	N∙m	
Mounting torque	Mt	Auxiliary terminals screw M3	0.4	-	0.8	N∙m	
mass	m			0.8	-	kg	
Comparative tracking index	CTI	-		-	-	-	
Clearance distance in air	d _a	Between main terminal		-	-	mm	
Creepage distance along surface	ds			-	-	mm	
	L _{P DS}	Between DC+ and DC-(terminal1,2-6,7)	-	28	-	nH	
Internal inductance, D-S		Between DC+ and AC, (terminal1,2-3,4,5)	-	50	-	nH	
	L _{PDS}	Between AC and DC-(terminal3,4,5-6,7)	-	50	-	nH	

Note 1. Control Case Temperature (T_c) so that the junction temperature (T_j) does not exceed the maximum rating.

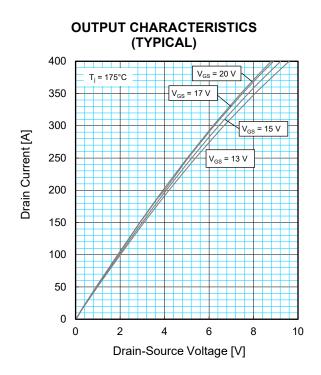
Note 2. The symbols represent characteristics of the anti-parallel, source to drain free-wheel diode (FWDi).

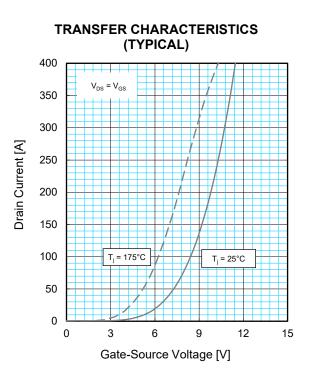
Note 3. Junction temperature (T_j) should not exceed T_{jmax} rating.

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

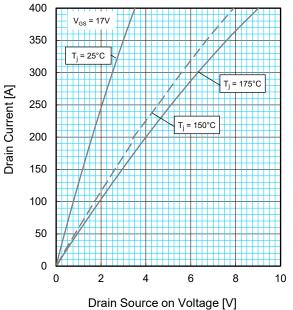
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PERFPRMANCE CURVES

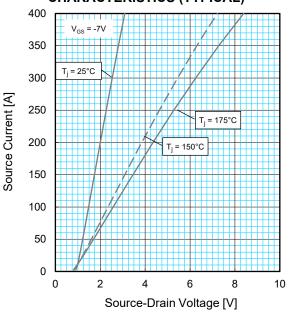




DRAIN-SOURCE ON VOLTAGE CHARACTERISTICS (TYPICAL)

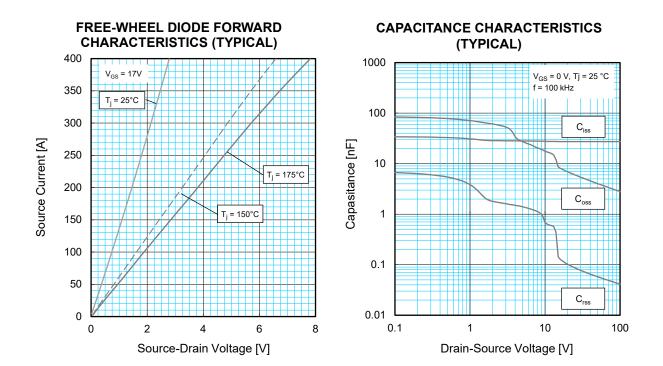


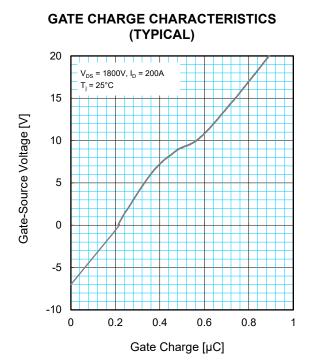
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



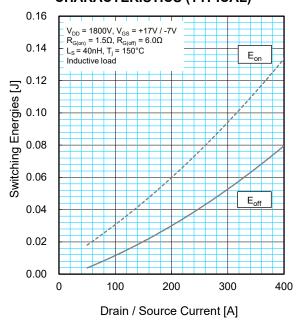
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PERFORMANCE CURVES



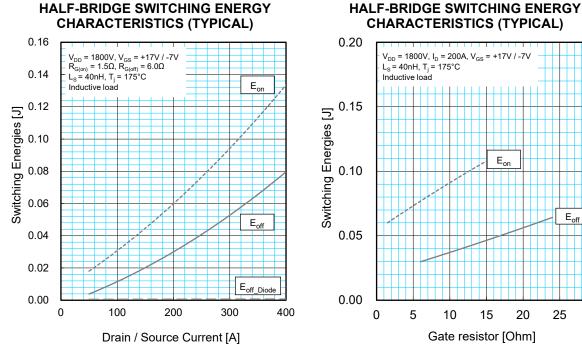


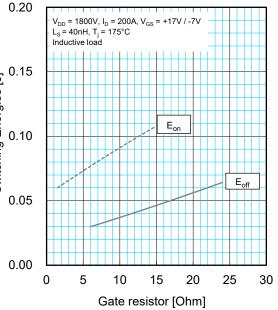
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



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PERFORMANCE CURVES





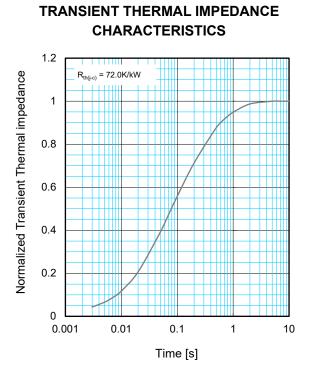
REVERSE BIAS SAFE OPERATING AREA SHORT CIRCUIT SAFE OPERATING AREA (SCSOA) (RBSOA) 600 4 $V_{DD} \le 2500V, V_{GS} = +17/-7V$ $T_j = 175^{\circ}C, t_{sc} \le 1.7\mu s$ VDD ≤ 2500V, VGS = +17/-7V $R_{G(off)} = 6.0 \ \Omega, \ T_j = 175^{\circ}C$ 3.5 500 3 Drain Current [A] 400 Drain Current [kA] 2.5 300 2 1.5 200 1 100 0.5 0 0 0 1000 2000 3000 0 1000 2000 3000 4000 Drain-Source Voltage [V]

Drain-Source Voltage [V]

4000

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PERFORMANCE CURVES



$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$

	1	2	3	4
R_i/R_{th} :	0.0078	0.1975	0.3553	0.4393
τ _i [sec.] :	0.0001	0.7324	0.0381	0.1698

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